Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/790,142	SENDAI ET AL.	
Examiner	Art Unit	_
Shun Lee	2884	

	SEAR	CHED	=
Class	Subclass	Date	Examiner
250	252.1	3/15/2006	SL
378	207	3/15/2006	SL
Above	UPDATED	9/19/2006	SL

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
1			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	9/19/2006	SL